CDA 4213/CIS 6930 CMOS VLSI Design Instructor: Dr. Srinivas Katkoori

Fall 2019

Final Project: N x N Array Multiplier Design

Handed out on 28th October 2019 (Monday)
Final Demo Date: 9th December 2019 (Monday)
This project is worth 25% of the lecture grade and 50% of the lab grade! Start early!

1 Introduction

You will design a custom Application Specific Integrated Circuit (ASIC) implementation of an N x N array multiplier. The ASIC will be fabricated in AMI $0.5\mu m$ CMOS technology available through MOSIS.

2 Background and Requirements

You already know how to multiply two binary numbers. Figure 1^1 shows an example of multiplication of two unsigned 6-bit numbers. The first number (12_{10}) is the *multiplicand* and second number (5_{10}) is the *multiplier*. Six partial products (rows) are generated which when summed column wise yields the product (60_{10}) .

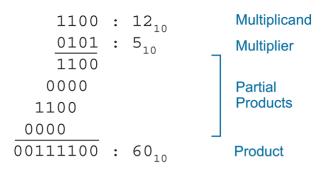


FIG 10.67 Multiplication example

Figure 1: Binary Multiplication - An Example

If the multiplicand is represented by $Y = \{y_{M-1}, y_{M-2}, \dots, y_1, y_0\}$, and multiplier as $X = \{x_{N-1}, x_{N-2}, \dots, x_1, x_0\}$, then the product, P, is given by Equation 1. The inner summation results in partial products while the outer one sums the partial products. This can be depicted as in Figure 2. Note that M = N in this project.

¹Note the figures are from Weste and Harris, 3rd edition.

FIG 10.68 Partial products

Figure 2: Partial Products

$$P = \sum_{j=0}^{M-1} y_j 2^j \sum_{i=0}^{N-1} x_i 2^i = \sum_{i=0}^{N-1} \sum_{j=0}^{M-1} x_i y_j 2^{i+j}$$
 (1)

Consider a bit-sliced implementation of a 4-bit multiplier as shown in Figure 3. The multiplicand is fed vertically, while the multiplier is fed horizontally. There are two bit slices used in this design; the first one (rectangle with sharp corners) multiplies two bits (i.e., ANDs A and B) and then performs a sum of three bits (AB, S_{in} , C_{in}). The second slice (with rounded corners) performs a three bit sum (A, B, and C_{in}). This implementation uses Carry Save Adders (CSA) along the rows. A CSA, unlike a ripple carry adder, saves the sums and passes them to the CSA in the succeeding row. The critical path for the circuit is shown by a dashed line. The sum of delays of module instances along the critical path will be the worst-case delay and thus will dictate how fast we can multiplier two numbers.

Figure 4 shows a rectangular layout of the array multiplier.

Read Section 11.9 and 11.9.1 (pages 476 - 479) in Weste and Harris text book (4th edition) for a detailed discussion on the array multiplier.

2.1 Design Requirements

Your team is called upon to layout an $N \times N$ array multiplier in a given area (approximately $0.8mm^2$). The following are the design requirements and objectives:

- 1. Implement a rectangular layout.
- 2. The inputs X and Y are fed serially to the multiplier.
- 3. Both X and Y should be registered.
- 4. You need to maximize N.

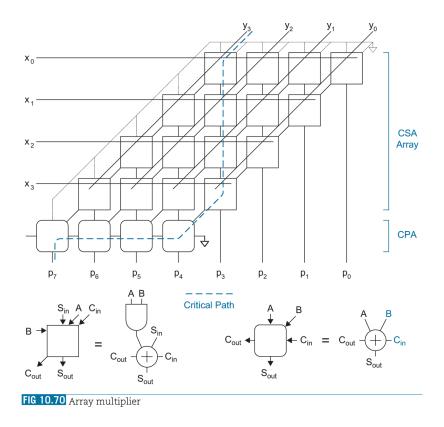


Figure 3: A 4-bit Array Mutliplier

- 5. Product P should be registered and clocked out serially.
- 6. The three registers are clocked by an external clock signal.

2.2 Design Goals and Constraints:

- Functionality: Your design should work for atleast 8 (eight) input cases.
- Area: You are limited by the chip area of approximately $900\mu m \times 900\mu m$. You must incorporate your layout in the TinyChip Padframe provided by MOSIS and made available to you on Canvas.
- **Performance:** As such there is no minimum clock constraint, however, you should determine what is the fastest clock speed your design will work at.
- **Power:** Again there is no power budget; however you should measure the average and peak power consumption of your design using the test cases provided.
- I/O Pin Constraint: TinyChip has 40 pads. You will be provided with a pin-mapping diagram that you should adhere to strictly.

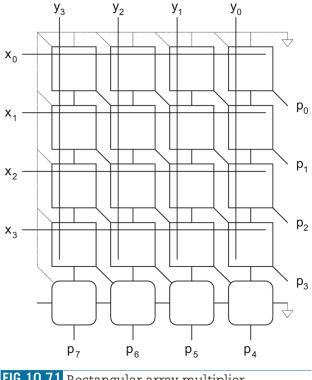


FIG 10.71 Rectangular array multiplier

Figure 4: Rectangular Array Mutliplier

• Testability: The ASIC can be put in test mode (by setting input TEST=1). We should be able to test the X, Y, and P registers in a scan-chain mode. A scan chain is formed with the three registers cascaded to form one long serial register.

2.3 **Design Validation**

You must validate your design by simulation using Spectre. You need to show the simulation results for two modes:

- Normal mode: You will be provided with 8 test cases for which your design should work correctly.
- Test Mode: You will be provided with 2 test cases for which your design should work correctly.

Extra Credit (10%) On board clock generation with ability to select internal and external clock signal.

3 Deadlines and Deliverables

The following are the deliverables for this project:

- 1. **Design Proposal (10%)**: This proposal must outline a detailed design, project schedule, important milestones, and work distribution. A template will be provided.
 - Due: 11:59PM, Wednesday, 6th November.
- 2. **Partial Design (50%)**: A working design of N x N multiplier along with the registers outside the padframe. A design report must be submitted. A template will be provided.

Due: Week of 18th November. You must demo in any of the lab sessions in that week.

- 3. ASIC Layout (30%): A complete working layout in the pad frame.

 Due: Project Demo during Exam Week, Monday, 9th December.
- 4. **Project Report (10%)**: An extension of the report you submitted for partial design, that includes all design decisions, cell level information, block diagrams, simulation results, layouts, etc.

Due: Within 2 days after your final project demo.

Project Demonstration Your group needs to demonstrate your project on 9th December 2019. A signup sheet will be posted on TAs' door (ENB 249A) one week before the demo date.

4 Tips

- Start early! You should complete the layout (without padframe) at least ten days before the deadline. In the following ten days you can integrate the layout in the padframe and test it thoroughly. Note that the simulations take time.
- The following is a suggested development plan:
 - (1) Block level design and layout
 - (2) Integration of the blocks
 - (3) Simulation of entire design (outside pad frame)
 - (4) Integration with pad frame
 - (5) Simulation with pad frame.
- Ensure that you buffer the signals that travel long distances. Especially the clock signal must be buffered well.
- To prevent latch-up you need to use well/substrate contacts liberally throughout your design.
- VDD, GND, CLK, and RST wires must be made as thick as possible to prevent any electromigration problems.

Good Luck!